

FQP5N20-VB Datasheet

N-Channel 200 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|----------------------------|-----------------------------|--|--|--|--|
| V _{DS} (V) | 200 | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V 0.91 | | | | |
| Q _g (Max.) (nC) | 13 | | | | |
| Q _{gs} (nC) | 3.0 | | | | |
| Q _{gd} (nC) | 7.9 | | | | |
| Configuration | Single | | | | |

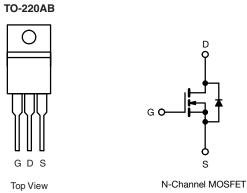
FEATURES

- TrenchFET[®] Power MOSFET
- 175 °C Junction Temperature
- **PWM Optimized**
- 100 % R_a Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

• Primary Side Switch





| ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise PARAMETER | | | SYMBOL | LIMIT | UNIT | |
|---|---|-------------------------|---|-------------|------|--|
| Drain-Source Voltage | | | V _{DS} | 200 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | | |
| Continuous Drain Current | $V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_{C} = 25 \text{ °C}}{T_{C} = 100 \text{ °C}}$ | | | 5.0 | А | |
| Continuous Drain Current | | T _C = 100 °C | ID | 4.0 | | |
| Pulsed Drain Current ^a | | | I _{DM} | 20 | | |
| Linear Derating Factor | | | | 0.33 | W/°C | |
| Linear Derating Factor (PCB Mount) ^e | | | | 0.020 | W/ C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 161 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 4.8 | А | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 4.2 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | | 42 | w | |
| Maximum Power Dissipation (PCB mount) e | T _A = 25 °C | | P _D | 2.5 | vv | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 5.0 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} -55 to +150 | -55 to +150 | | |
| Soldering Recommendations (Peak temperature) d | for 10 s | | | 260 | °C | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 14 mH, $R_g = 25 \Omega$, $I_{AS} = 4.8 \text{ A}$ (see fig. 12). c. $I_{SD} \leq 5.2 \text{ A}$, dI/dt $\leq 95 \text{ A/}\mu$ s, $V_{DD} \leq V_{DS}$, $T_J \leq 150 \text{ °C}$.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).



| THERMAL RESISTANCE RAT | AL RESISTANCE RATINGS | | | | |
|---|-----------------------|------|------|------|------|
| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R _{thJA} | - | - | 110 | |
| Maximum Junction-to-Ambient (PCB mount) ^a | R _{thJA} | - | - | 50 | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | - | 3.0 | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER | SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|-----------------------|---|---|------------|-----------|----------------------|------------------|
| Static | | - | | | | | I |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} | = 0 V, I _D = 250 μΑ | 200 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | ce to 25 °C, I _D = 1 mA | - | 0.29 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | | = 200 V, V _{GS} = 0 V /, V _{GS} = 0 V, T _J = 125 °C | - | - | 25 250 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 2.9 A ^b | - | 0.91 | - | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} = | 50 V, I _D = 2.9 A ^b | 1.7 | - | - | S |
| Dynamic | | - | | | | | 1 |
| Input Capacitance | C _{iss} | $V_{GS} = 0 V$, | | - | 185 | - | pF |
| Output Capacitance | Coss | | $V_{\rm DS} = 25 \text{ V},$ | | 100 | - | |
| Reverse Transfer Capacitance | C _{rss} | f = 1 | .0 MHz, see fig. 5 | - | 30 | - | |
| Total Gate Charge | Qg | | | - | - | 13.0 | |
| Gate-Source Charge | Q _{gs} | $V_{GS} = 10 V$ | I _D = 4.8 A, V _{DS} = 160 V, see fig. 6 and 13 ^b | - | - | 3.0 | nC |
| Gate-Drain Charge | Q _{gd} | | 7. | | 7.9 | | |
| Turn-On Delay Time | t _{d(on)} | | | - | 7.2 | - | |
| Rise Time | t _r | V _{DD} = | V _{DD} = 100 V, I _D = 4.8 A, | | 22 | - | ns |
| Turn-Off Delay Time | t _{d(off)} | $R_G = 18 \Omega$, $R_D = 20 \Omega$, see fig. 10 b | | - | 19 | - | |
| Fall Time | t _f | | | - | 13 | - | 1 |
| Internal Drain Inductance | L _D | 6 mm (0.25") | Between lead, 6 mm (0.25") from | | 4.5 | - | |
| Internal Source Inductance | L _S | package and die contact | center of | - | 7.5 | - | nH |
| Drain-Source Body Diode Characteristic | s | • | | | | | • |
| Continuous Source-Drain Diode Current | I _S | showing the | MOSFET symbol showing the | | - | 4.8 | ^ |
| Pulsed Diode Forward Current ^a | I _{SM} | p - n junction diode | | 19 | A | | |
| Body Diode Voltage | V _{SD} | T _J = 25 °C | , $I_{S} = 4.8$ A, $V_{GS} = 0$ V ^b | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t _{rr} | T 05 %C 1 | 4.9.4 dl/d+ 100.4/ h | - | 150 | 300 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | $I_{\rm J} = 25 {}^{-}{\rm C}, I_{\rm F}$ | = 4.8 A, dl/dt = 100 A/µs ^b | - | 0.91 | 1.8 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic tu | ırn-on time is negligible (turn | -on is dor | ninated b | y L _S and | L _D) |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

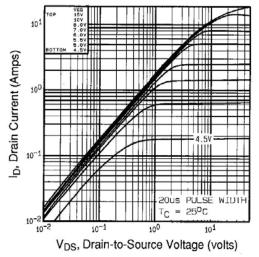


Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

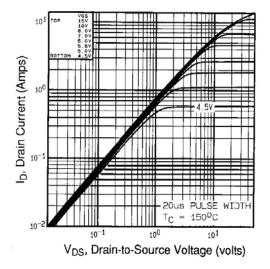


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

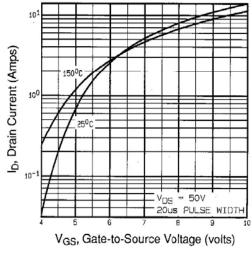


Fig. 3 - Typical Transfer Characteristics

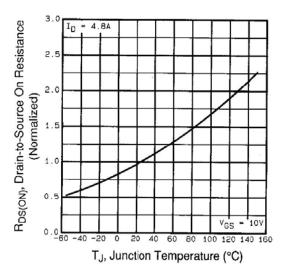


Fig. 4 - Normalized On-Resistance vs. Temperature



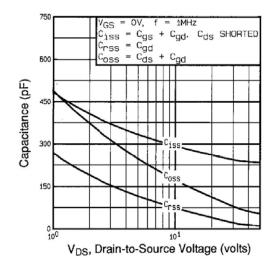


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

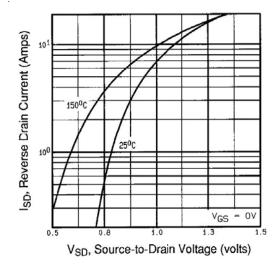


Fig. 7 - Typical Source-Drain Diode Forward Voltage

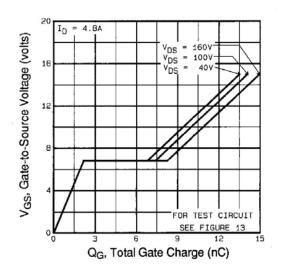


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

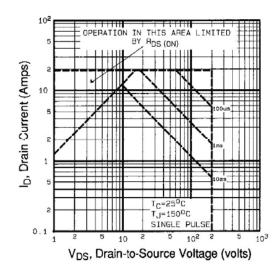


Fig. 8 - Maximum Safe Operating Area



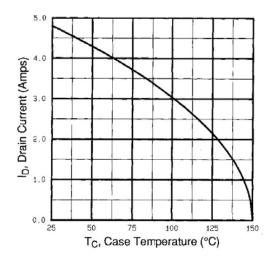


Fig. 9 - Maximum Drain Current vs. Case Temperature

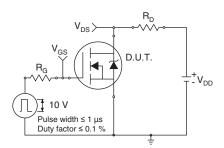


Fig. 10a - Switching Time Test Circuit

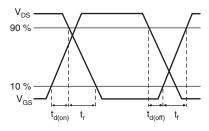


Fig. 10b - Switching Time Waveforms

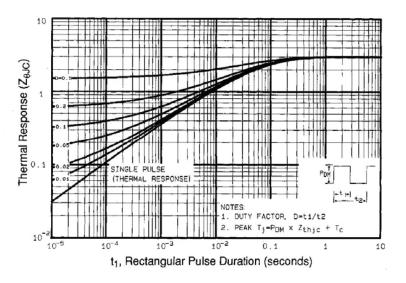


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



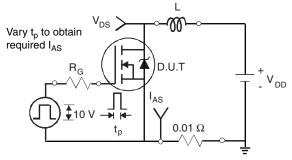


Fig. 12a - Unclamped Inductive Test Circuit

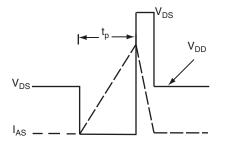


Fig. 12b - Unclamped Inductive Waveforms

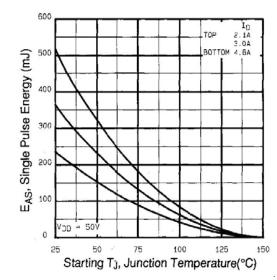


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

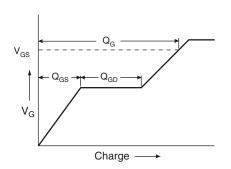


Fig. 13a - Basic Gate Charge Waveform

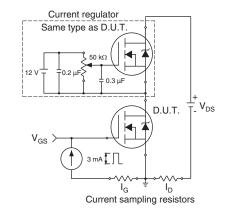
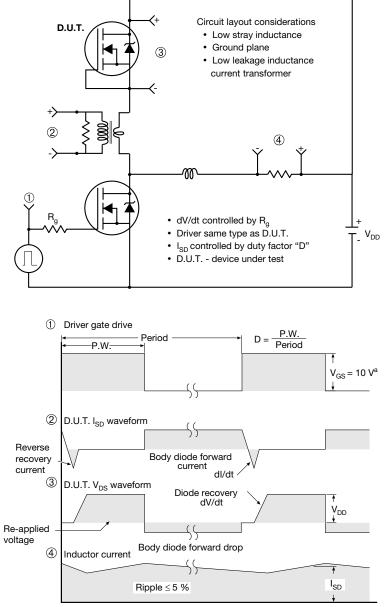


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



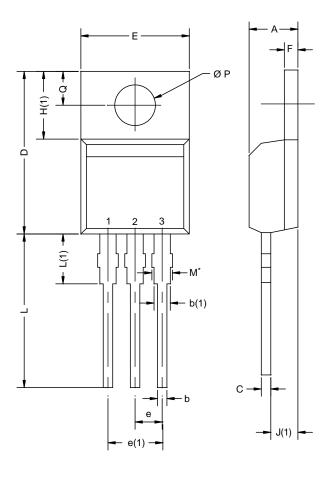
Note

a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



| | MILLIN | IETERS | INC | HES |
|-----------------------|-------------------|-----------|-------|-------|
| DIM. | MIN. | MAX. | MIN. | MAX. |
| А | 4.25 | 4.65 | 0.167 | 0.183 |
| b | 0.69 | 1.01 | 0.027 | 0.040 |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 |
| С | 0.36 | 0.61 | 0.014 | 0.024 |
| D | 14.85 | 15.49 | 0.585 | 0.610 |
| Е | 10.04 | 10.51 | 0.395 | 0.414 |
| е | 2.41 | 2.67 | 0.095 | 0.105 |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 |
| F | 1.14 | 1.40 | 0.045 | 0.055 |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 |
| L | 13.35 | 14.02 | 0.526 | 0.552 |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 |
| Q | 2.60 | 3.00 | 0.102 | 0.118 |
| ECN: X12- DWG: 547 | 0208-Rev. N, 1 | 08-Oct-12 | | |

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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